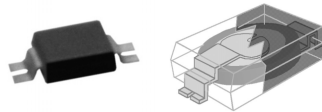


Surface Mount Disc Capacitors

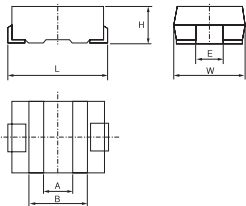
Introduction

- Samwha's high voltage ceramic capacitors offer superior performance and reliability.
- SMDC is the resin molded SMD type that surface mounting is available.
- SMDC exhibits high reliability through use of disc capacitor element.
- Competitive lower maintenance cost is guaranteed.
- Wide rated voltage ranges from 1kV to 6kV, through a disc element which withstand high voltage and outcurve terminals.
- Design flexibility ensures down sizing and higher resistance to outer impact.

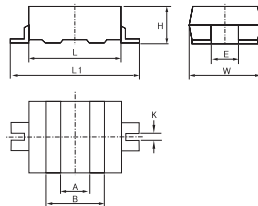
Shape & Dimensions



Inside Terminal (Style 1)
(Development Product)



Outside Terminal (Style 2)
(Mass Product)



(Unit : mm)

| Rated Voltage | Capacitance (pF) | L ±0.5 | W ±0.3 | H ±0.2 | E ±0.2 | A | B | K ±0.1 | L1 ±0.3 | L2 Min. | Terminal Form | Development/Mass |
|---------------|------------------|--------|--------|--------|--------|-----|-----|--------|---------|---------|---------------|------------------|
| 3kV | 5 ~ 33 | 5.7 | 4.5 | 2.3 | 2.5 | 1.7 | 3.1 | - | - | - | Style 1 | Development |
| | 5 ~ 33 | 5.7 | 4.5 | 2.3 | 2.5 | 1.7 | 3.1 | - | - | - | Style 1 | Development |
| 4kV | 39 ~ 47 | 7.1 | 6.3 | 2.4 | 2.5 | 2.0 | 3.7 | - | - | - | Style 1 | Development |
| | 18 ~ 27 | 5.5 | 4.5 | 2.3 | 2.5 | 1.7 | 3.1 | 0.5 | 9.4 | 6.7 | Style 2 | Mass |
| | 39 ~ 47 | 7.1 | 6.3 | 2.4 | 2.5 | 2.0 | 3.7 | 0.5 | 10.8 | 7.9 | Style 2 | Development |
| 5kV | 5 ~ 15 | 5.5 | 4.5 | 2.3 | 2.5 | 1.7 | 3.1 | 0.5 | 9.4 | 6.7 | Style 2 | Mass |
| | 18 ~ 27 | 7.1 | 6.3 | 2.4 | 2.5 | 2.0 | 3.7 | 0.5 | 10.8 | 7.9 | Style 2 | Development |
| 6kV | 5 ~ 15 | 7.1 | 6.3 | 2.4 | 2.5 | 2.0 | 3.7 | 0.5 | 10.8 | 7.9 | Style 2 | Development |

How to Order (Product Identification)

SCC O 3H 150 J 2 E 00



1 Style

| Mark | Product Name | Mark | Product Name |
|------|-------------------------------|------|-------------------------------------|
| SCC | Temperature Compensating Type | SSD | AC250/400V(Testing Voltage:AC4000V) |
| SCK | High Dielectric Type | SSC | AC250(Testing Voltage:AC2500V) |
| SCG | Semiconductor Type | | |

2 Capacitance temperature characteristic

| SCC Type (PPM/°C) | | SCK, SCG, SSC, SSD Type | |
|-------------------|------------|-------------------------|----------------|
| C | NPO(0) | T | N470(-470) |
| L | N80(-80) | U | N750(-750) |
| P | N150(-150) | O | SL(+350~-1000) |
| R | N220(-220) | | |
| S | N330(-330) | | |
| | | B | Y5P(+10~-10%) |
| | | R | Y5R(+15~-15%) |
| | | E | Y5U(+22~-56%) |
| | | F | Y5V(+22~-82%) |

3 Rating Voltage

| | | | | | | | | | | | | | |
|----|------|----|--------|----|-----|----|------|----|--------|------|-----|------|-------|
| 1A | 10V | 1B | 12.5V | 1C | 16V | 1E | 25V | | | 1H | 50V | | |
| 2A | 100V | 2B | 125V | | | 2E | 250V | | 2G | 400V | 2H | 500V | |
| 3A | 1kV | 3B | 1.25kV | 3D | 2kV | | | 3F | 3.15kV | 3G | 4kV | 3H | 5kV |
| 4A | 10kV | 4B | 16kV | | | | | | | | | 3J | 6.3kV |

4 Capacitance

(in picofarads) The first two digits indicate significant digits. The 3rd digit indicate the number of zero following.
R denotes decimal. Ex.) 0.5pF : 0R5, 10pF : 100, 100pF : 101

5 Cap. Tolerance

| Mark | Cap. Tolerance | Mark | Cap. Tolerance | Mark | Cap. Tolerance |
|------|----------------|------|----------------|------|----------------|
| C | ±0.25pF | J | ±5% | P | +100%, -0% |
| D | ±0.5pF | K | ±10% | Z | +80%, -20% |
| F | ±1.0pF | M | ±20% | | |

6 Style

| Mark | Terminal Form |
|------|------------------|
| 1 | Inside Terminal |
| 2 | Outside Terminal |

7 Packing Style

| Mark | Packaging Style |
|------|-------------------------|
| B | Bulk |
| E | Embossed Carrier Taping |

8 Spare Code

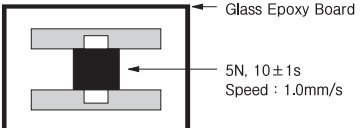
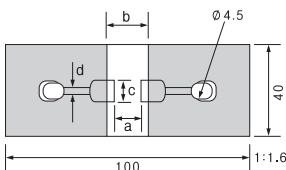
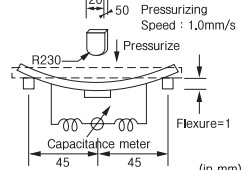
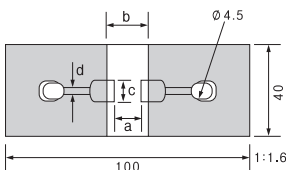
Electrical Performance

| No. | Item | Requirement | | Test Conditions | | | | | | |
|-----|---|---|---|---|----|-----|------|-----|-----------|----------|
| | | SCC Type | SCK, SCG, SSC, SSD Type | | | | | | | |
| 1 | Operating Temperature Range | -25°C ~ 110°C | B,E: -25°C ~ +85°C F : +10°C ~ +65°C | | | | | | | |
| 2 | Capacitance | Within the specified range | | - Temperature : 20±2°C - Frequency : 1±0.1MHz(SCC Type) 1±0.1KHz (SCK,SCG,SSC,SSD Type) | | | | | | |
| 3 | Dissipation Factor (tan δ, Q) | Q ≥ 400+20C (C : capacitance, pF) | B,E : 2.5% Max. F : 5.0% Max. | - Relative Humidity : 60-70% - Measure voltage : 1±0.1Vrms | | | | | | |
| 4 | Insulation resistance | More than 1000MΩ | | - Applied Voltage : • To be below 500V - Rating Voltage • Above 500V - 500V - Charge Time : 60±5sec | | | | | | |
| 5 | Dielectric Withstanding Voltage | No remarkable abnormality is recognized | | - Testing Voltage <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>RV</th> <th>3kV</th> <th>4kV~</th> </tr> </thead> <tbody> <tr> <td>W.V</td> <td>RV × 1.75</td> <td>RV × 1.5</td> </tr> </tbody> </table> For 1 to 5 sec.(Between terminals) The discharge current, however was 50 mA or less | RV | 3kV | 4kV~ | W.V | RV × 1.75 | RV × 1.5 |
| RV | 3kV | 4kV~ | | | | | | | | |
| W.V | RV × 1.75 | RV × 1.5 | | | | | | | | |
| 6 | Capacitance temperature Characteristics | | | Based on Items 2.2. 12 of EIA RS-198-C | | | | | | |

Temperature and Humidity Test Characteristics

| No. | Item | Requirement | | Test Conditions | | | | | | | | | | | | | | | | |
|-------------------------------|--------------------------|--------------------------------|--|--|--|------|-----------------|-----------------|---|-----------|----|---|-------------------------|-------|---|-----------|----|---|-------------------------|-------|
| | | SCC Type | SCK, SCG, SSC, SSD Type | | | | | | | | | | | | | | | | | |
| 1 | High Temperature Test | Appearance | No. visible damage | | - Temperature : 85±2°C - Test voltage : 1.2 times of the rated voltage - Operating time of test: 1000 +48/-0 hours After testing, The capacitor shall be subjected to the standard test condition for a period 4-24 hours and shall be measured. Charge and discharge current shall be 50 mA or less. ※Standard test condition : - Temperature : 20±2°C - Frequency : 1±0.1MHz(SCC Type) 1±0.1KHz (SCK, SCG, SSC, SSD Type) | | | | | | | | | | | | | | | |
| | | Capacitance Change | ±5% or ±0.5 pF Whichever is larger from initial measurement | B : With ± 10% E : With ± 20% F : With ± 30% | | | | | | | | | | | | | | | | |
| | | Dissipation Factor (tan δ, Q) | Q ≥ 200 | B,E : 5% Max. F : 7.5% Max. | - Relative Humidity : 60 ~ 70% - Measure voltage : 1± 0.1Vrms | | | | | | | | | | | | | | | |
| | | IR | More than 2000MΩ | | | | | | | | | | | | | | | | | |
| 2 | Humidity Resistance Test | Appearance | No. visible damage | | - Temperature : 40±2°C - Relative Humidity : 90-95% R.H - Operating time of test : 500 +24, -0 hours After testing, The capacitor shall be subjected to the standard test condition for a period 4-24 hours and shall be measured. Charge and discharge current shall be 50 mA or less. ※Standard test condition : - Temperature : 20±2°C - Frequency : 1± 0.1MHz(SCC Type) 1± 0.1KHz (SCK, SCG, SSC, SSD Type) | | | | | | | | | | | | | | | |
| | | Capacitance Change | ±5% or ±0.5 pF Whichever is larger from initial measurement | B : With ± 10% E : With ± 20% F : With ± 30% | - Relative Humidity : 60 ~ 70% - Measure voltage : 1± 0.1Vrms | | | | | | | | | | | | | | | |
| | | Dissipation Factor (tan δ, Q) | Q ≥ 200 | B,E : 5% Max. F : 7.5% Max. | | | | | | | | | | | | | | | | |
| | | IR | More than 500MΩ | | | | | | | | | | | | | | | | | |
| 3 | Temperature Cycle Test | Appearance | No. visible damage | | - The capacitors shall be subjected to 5cycles of the temperature cycle under Table. | | | | | | | | | | | | | | | |
| | | Capacitance Change | ±5% or ±0.5 pF Whichever is larger from initial measurement | B : With ± 10% E : With ± 20% F : With ± 30% | <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>Step</th> <th>Temperature(°C)</th> <th>Period(minutes)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>-25, ±0/3</td> <td>30</td> </tr> <tr> <td>2</td> <td>Standard test condition</td> <td>10-15</td> </tr> <tr> <td>3</td> <td>+85, ±0/3</td> <td>30</td> </tr> <tr> <td>4</td> <td>Standard test condition</td> <td>10-15</td> </tr> </tbody> </table> After testing, The capacitor shall be subjected to the standard test condition for a period 4-24 hours and shall be measured. Charge and discharge current shall be 50 mA or less. ※Standard test condition : - Temperature : 20±2°C - Frequency : 1± 0.1MHz(SCC Type) 1± 0.1KHz (SCK, SCG, SSC, SSD Type) | Step | Temperature(°C) | Period(minutes) | 1 | -25, ±0/3 | 30 | 2 | Standard test condition | 10-15 | 3 | +85, ±0/3 | 30 | 4 | Standard test condition | 10-15 |
| | | Step | Temperature(°C) | Period(minutes) | | | | | | | | | | | | | | | | |
| | | 1 | -25, ±0/3 | 30 | | | | | | | | | | | | | | | | |
| 2 | Standard test condition | 10-15 | | | | | | | | | | | | | | | | | | |
| 3 | +85, ±0/3 | 30 | | | | | | | | | | | | | | | | | | |
| 4 | Standard test condition | 10-15 | | | | | | | | | | | | | | | | | | |
| Dissipation Factor (tan δ, Q) | Q ≥ 200 | B,E : 5% Max. F : 7.5% Max. | - Relative Humidity : 60 ~ 70% - Measure voltage : 1± 0.1Vrms | | | | | | | | | | | | | | | | | |
| IR | More than 1000MΩ | | | | | | | | | | | | | | | | | | | |

Mechanical test and Environmental Substance

| No. | Item | Requirement | | Test Conditions | |
|-----|--|--|--|--|---|
| | | SCC Type | SCK, SCG, SSC, SSD Type | | |
| 1 | Adhesive Strength of Terminal | No removal of the termination or other defect should occur. | | <p>Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 2 using a eutectic solder. Then apply 5 N force in the direction of the arrow. The soldering should be used the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.</p>  <p>Fig.2</p> | |
| 2 | Vibration Resistance | Appearance | No. visible damage | | <p>The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2hrs. in each 3 mutually perpendicular directions (total of 6hrs.)</p> |
| | | Capacitance Change | ±5% or ±0.5 pF Whichever is larger from initial measurement | B : With ± 10% E : With ± 20% F : With ± 30% | |
| | | Dissipation Factor (tan δ, Q) | Q ≥ 200 | B,E : 5% Max. F : 7.5% Max. | |
| | | I.R | More than 1000MΩ | | |
| 3 | Bending Strength | Appearance | No. visible damage | | <p>Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 3 using a eutectic solder. Then apply a force in the direction shown in Fig. 4. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.</p>  <p>Fig.3</p>  <p>Fig.4</p> |
| | | Capacitance Change | ±5% or ±0.5 pF Whichever is larger from initial measurement | B : With ± 10% E : With ± 20% F : With ± 30% | |
| | |  <p>Fig.3</p> | | | |
| 4 | Solderability Test | Visual examination terminals area shall be at least 90% covered with a new solder coating | | <p>Soldering Method : Reflow Soldering</p> <ul style="list-style-type: none"> - Maximum Temperature : 250°C max. (245 ± 5°C, 5 ± 0.5 sec.) - Preheating Temperature : 150~180°C, 60~180 sec. | |
| 5 | Solder Heat Resistance | Appearance | No. visible damage | | <p>Soldering Method : Reflow Soldering</p> <ul style="list-style-type: none"> - Maximum Temperature : 250°C max. (245 ± 5°C, 5 ± 0.5 sec.) - Preheating Temperature : 150~180°C, 60~180 sec. - After testing, The capacitors shall be subjected to the standard test condition for a period 24 hours and shall be measured. |
| | | Capacitance Change | ±5% or ±0.5 pF Whichever is larger from initial measurement | B : With ± 5% E : With ± 15% F : With ± 20% | |
| | | Dielectric Strength | No. Failure | | |
| 6 | The regulation of environmental pollution materials. | <ul style="list-style-type: none"> ※ Never use materials mentioned below in high voltage products regulated this document. ※ Pb, Hg, Cr+6, PBB, PBDE : 100ppm, Cd : 5ppm ※ Exception : - Pb of solder : <1000ppm - Pb of ceramic(dielectric) | | | |